

MEMS Gyroscope Metrics

1. Scale Factor : S

def: The ratio of change in output to a change in input

$$[S] = \text{mV}/\text{o/s}$$

→ evaluated as the slope of the least squares straight line fit to the input-output data

a. Scale Factor Errors

- ① Linearity Error - linear deviation from the least squares straight line fit
- ② Nonlinearity Error - nonlinear deviation from the least squares straight line fit
- ③ Scale Factor Temperature Sensitivity
- ④ Scale Factor Acceleration Sensitivity
- ⑤ Asymmetry Error - the difference in the scale factor between a $+ \Omega$ input and a $- \Omega$ input
- ⑥ Scale Factor Stability - how the scale factor varies over time of continuous gyro operation

2. Bias

def: the average gyro output voltage with zero input

ex: 2.5V is a common bias

i. $V_{out} > 2.5V$ for $\Omega > 0 \text{ o/s}$

$V_{out} < 2.5V$ for $\Omega < 0 \text{ o/s}$

a. Bias Error : ϵ

Typically expressed in $^{\circ}/\text{hr}$

∴ Resulting angular error: $\theta_e(t) = \epsilon t \rightarrow$ for zero input

b. Noise on Bias

The gyro's output is perturbed by zero-mean thermomechanical noise, which has an effect on the output signal

① Angle Random Walk

- The angular error buildup with time that is due to white noise in angular rate.

Typically expressed in $^{\circ}/\sqrt{\text{hr}}$ or $^{\circ}/\text{s}/\sqrt{\text{hr}}$

* remember: $\dot{\theta}_{\text{meas}}$ is produced, while $\theta(t)$ is desired:

$$\theta(t) = \int_0^t \dot{\theta}_{\text{meas}} dt, \text{ and } \dot{\theta}_{\text{meas}} \text{ is noisy}$$

② Bias stability

- The random variation in bias as computed over a specified finite time, and averaging time intervals

Typically expressed in $^{\circ}/\text{hr}$

③ Rate Random Walk

- The drift rate error buildup with time due to white noise in angular acceleration

Typically expressed in $^{\circ}/\text{hr}/\sqrt{\text{hr}}$

④ Other Related Bias Error Metrics

i. Power Spectral Density (PSD) : $(^{\circ}/\text{hr})^2/\text{Hz}$

ii. FFT Noise Density : $(^{\circ}/\text{hr})/\sqrt{\text{Hz}}$

iii. Noise Density (or rate noise density)

$$^{\circ}/\text{s}/\sqrt{\text{Hz}} \rightarrow \text{note: } \sqrt{\text{Hz}} = \sqrt{\text{BW}}$$

⑤ Bias Offset Calibration Error

- If the bias has a fixed DC offset \rightarrow then the measurement of SR will be off a fixed amount at all times
- An easy error to measure and correct for

⑥ Temperature Induced Bias Offset

- temperature can be measured on chip and used to null this error

3. Operating Characteristics

a. Resolution

- The nominal minimum detectable change in Input

b. Bandwidth

- The (typically 3dB) range in frequency of the angular rate input that can be detected

c. Turn-On Time

- time from power on to useful output

d. Linear and Angular Vibration Sensitivity

e. Mechanical Shock Resistance

f. Power Supply Sensitivity

① max/min voltages

② PSRR

③ Effect of supply voltage on output:

$\rightarrow \text{O/S/V}$